

Search Notes

Application No.

09/645,794

Examiner

Vanel Frenel

Applicant(s)

WALLACH ET AL.

Art Unit

3626

SEARCHED

Class	Subclass	Date	Examiner
705	4	1/21/2005	V.F

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West 2.0; USPAT; EPO; JPO; DERWENT WORLD PATENTS INDEX; IBM TECHNICAL DISCLOSURE BULLETINS	1/21/2005	V.F
PROQUEST	1/21/2005	V.F